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## 1.0 ENGINEERING TEST REPORT

1. Applicant

Address

d. Model No.

from which the following data has been derived properly complies with the requirements of "FCC Rules and Regulations Part 18 Subpart C" as of the date the measurements were made. Any modification to the unit as tested may invalidate the data and void

this certification.

This is to certify that the Commercial Microwave Oven/Model NE-2180,


: Matsushita Technology Corporation of America.

Address	9333 West Grand	Avenu,	Franklin F	<sup>o</sup> ark,	Illinois
	60131 U.S.A.				

: 800 Tsutsuicho-yamatokoriyama,

Nara Japan 639-1188

2.	Manufacturer	-:	Matsushita Electric Industrial Co., LTD.
			Microwave Oven Division

3. Description of	Appliance		

a. Name of Appliance	: Commercial Microwave Oven
h. Equipment authorization	on : Certification

u,	edarbmenc	author reaction	•	CELLILICATION	
	COO ID		_	101 100001	

- c. FCC ID. : ACLAQ3061
- e. Serial No. PP6021 f. Date of Manufacture : June 2001

: NE-2180

- g. Oscillating Frequency : Clock of Controller: 4.19MHz h. Operating Frequency : 2450MHz
- i. Highest Frequency : 2450MHz
- : 208V AC 60Hz j. Power Supply
- 4. Measurement Site : Matsushita EMC Center

- 5. Date of Measurement July 12 to 13, 2001
- 6. Summary of Mesurement Results a. Radiated Emission : minimum Limit Margine 31.02 µV/m(AV)
  - at 8134.07 MHz b. Safety Check of Leakage: Lower than the limit of 0.5 mW/cm<sup>2</sup>

These test results are traceable to the National and International Standards.

Mesurement Uncertainty, at time of test, and at least 95% confidence, was estimated to be as follows:

Radiated Emission Measurement : 2.6 dB

Katsuo Ishihara

Karsur Ishihara

Chief Engineer of Matsushita EMC Center

Date : July 19, 2001